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Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,905	SON, KWEON
Examiner	Art Unit
Joseph L. Perrin, Ph.D.	1746

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Class	Subclass	Date	Examiner		
008	158-159	11/27/2006	JLP		
068	12.01,	11/27/2006	JLP		
068	12.12,	11/27/2006	JLP		
068	12.23	11/27/2006	JLP		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
SEe EAST search notes; no double patenting found.	11/27/2006	JLP	